



# BUK765R0-100E

## N-channel TrenchMOS standard level FET

Rev. 2 — 16 May 2012

Product data sheet

## 1. Product profile

### 1.1 General description

Standard level N-channel MOSFET in a SOT404 package using TrenchMOS technology. This product has been designed and qualified to AEC Q101 standard for use in high performance automotive applications.

### 1.2 Features and benefits

- AEC Q101 compliant
- Repetitive avalanche rated
- Suitable for thermally demanding environments due to 175 °C rating
- True standard level gate with VGS(th) rating of greater than 1V at 175 °C

### 1.3 Applications

- 12V, 24V and 48V Automotive systems
- Electric and electro-hydraulic power steering
- Motors, lamps and solenoid control
- Start-Stop micro-hybrid applications
- Transmission control
- Ultra high performance power switching

### 1.4 Quick reference data

Table 1. Quick reference data

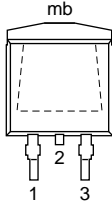
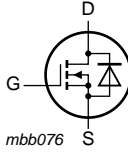
| Symbol                         | Parameter                        | Conditions   | Min | Typ | Max | Unit |
|--------------------------------|----------------------------------|--|-----|-----|-----|------|
| V <sub>DS</sub>                | drain-source voltage             | T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C  | -   | -   | 100 | V    |
| I <sub>D</sub>                 | drain current                    | V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; see <a href="#">Figure 1</a>  | [1] | -   | 120 | A    |
| P <sub>tot</sub>               | total power dissipation          | T <sub>mb</sub> = 25 °C; see <a href="#">Figure 2</a>  | -   | -   | 357 | W    |
| <b>Static characteristics</b>  |                                  |  |     |     |     |      |
| R <sub>DSon</sub>              | drain-source on-state resistance | V <sub>GS</sub> = 10 V; I <sub>D</sub> = 25 A; T <sub>j</sub> = 25 °C; see <a href="#">Figure 11</a>   | -   | 3.9 | 5   | mΩ   |
| <b>Dynamic characteristics</b> |                                  |  |     |     |     |      |
| Q <sub>GD</sub>                | gate-drain charge                | V <sub>GS</sub> = 10 V; I <sub>D</sub> = 25 A; V <sub>DS</sub> = 80 V; T <sub>j</sub> = 25 °C; see <a href="#">Figure 13</a> ; see <a href="#">Figure 14</a> | -   | 65  | -   | nC   |

[1] Continuous current is limited by package.



## 2. Pinning information

**Table 2. Pinning information**

| Pin | Symbol | Description                          | Simplified outline  | Graphic symbol  |
|-----|--------|--------------------------------------|---|---|
| 1   | G      | gate                                 |  |  |
| 2   | D      | drain                                |   |   |
| 3   | S      | source                               |   |   |
| mb  | D      | mounting base;<br>connected to drain |   |   |

**SOT404 (D2PAK)**

## 3. Ordering information

**Table 3. Ordering information**

| Type number   | Package |   | Version |
|---------------|---------|---|---------|
|               | Name    | Description   |         |
| BUK765R0-100E | D2PAK   | plastic single-ended surface-mounted package (D2PAK);<br>3 leads (one lead cropped) | SOT404  |

## 4. Marking

**Table 4. Marking codes**

| Type number   | Marking code  |
|---------------|---------------|
| BUK765R0-100E | BUK765R0-100E |

## 5. Limiting values

**Table 5. Limiting values**

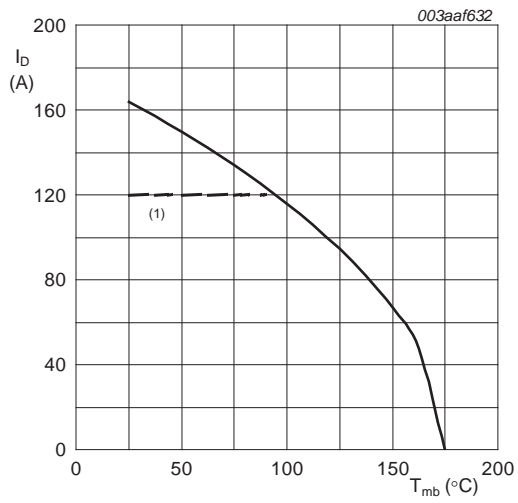
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol                      | Parameter                                    | Conditions   | Min    | Max | Unit |    |
|-----------------------------|--|--|--------|-----|------|----|
| $V_{DS}$                    | drain-source voltage                         | $T_j \geq 25\text{ °C}$ ; $T_j \leq 175\text{ °C}$   | -      | 100 | V    |    |
| $V_{DGR}$                   | drain-gate voltage                           | $R_{GS} = 20\text{ k}\Omega$   | -      | 100 | V    |    |
| $V_{GS}$                    | gate-source voltage                          |  | -20    | 20  | V    |    |
| $I_D$                       | drain current                                | $T_{mb} = 25\text{ °C}$ ; $V_{GS} = 10\text{ V}$ ; see <a href="#">Figure 1</a>  | [1]    | -   | 120  | A  |
|                             |  | $T_{mb} = 100\text{ °C}$ ; $V_{GS} = 10\text{ V}$ ; see <a href="#">Figure 1</a>   | -      | -   | 115  | A  |
| $I_{DM}$                    | peak drain current                           | $T_{mb} = 25\text{ °C}$ ; pulsed; $t_p \leq 10\text{ }\mu\text{s}$ ; see <a href="#">Figure 4</a>  | -      | 650 | A    |    |
| $P_{tot}$                   | total power dissipation                      | $T_{mb} = 25\text{ °C}$ ; see <a href="#">Figure 2</a>   | -      | 357 | W    |    |
| $T_{stg}$                   | storage temperature                          |  | -55    | 175 | °C   |    |
| $T_j$                       | junction temperature                         |  | -55    | 175 | °C   |    |
| <b>Source-drain diode</b>   |  |  |        |     |      |    |
| $I_S$                       | source current                               | $T_{mb} = 25\text{ °C}$  | [1]    | -   | 120  | A  |
| $I_{SM}$                    | peak source current                          | pulsed; $t_p \leq 10\text{ }\mu\text{s}$ ; $T_{mb} = 25\text{ °C}$   | -      | 650 | A    |    |
| <b>Avalanche ruggedness</b> |  |  |        |     |      |    |
| $E_{DS(AL)S}$               | non-repetitive drain-source avalanche energy | $I_D = 120\text{ A}$ ; $V_{sup} \leq 100\text{ V}$ ; $R_{GS} = 50\text{ }\Omega$ ; $V_{GS} = 10\text{ V}$ ; $T_{j(init)} = 25\text{ °C}$ ; unclamped; see <a href="#">Figure 3</a> | [2][3] | -   | 385  | mJ |

[1] Continuous current is limited by package.

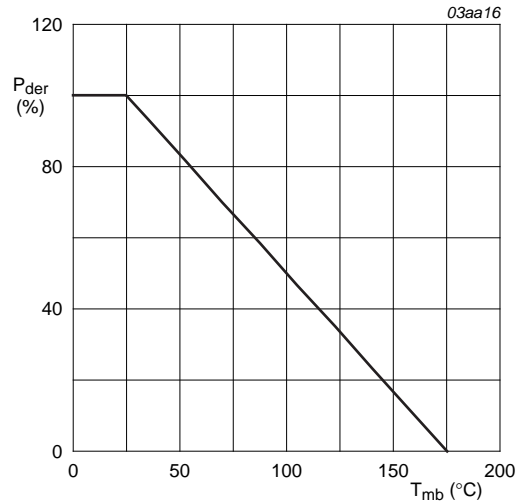
[2] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.

[3] Refer to application note AN10273 for further information.



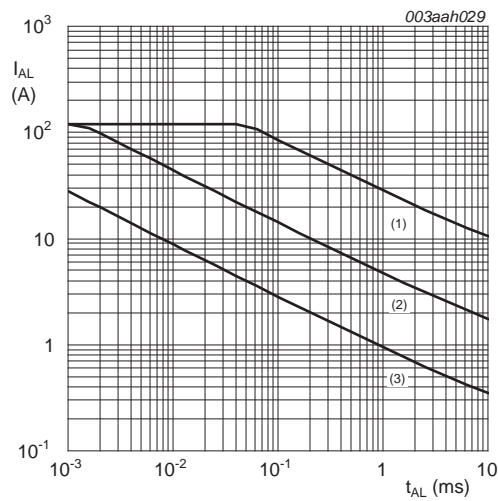
$V_{GS} \geq 10V$   
 (1) Capped at 120 A due to package.

**Fig 1. Continuous drain current as a function of mounting base temperature**



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

**Fig 2. Normalized total power dissipation as a function of mounting base temperature**



(1)  $T_j(amb) = 25^{\circ}C$ ; (2)  $T_j(amb) = 150^{\circ}C$ ; (3) Repetitive Avalanche

**Fig 3. Single-pulse and repetitive avalanche rating; avalanche current as a function of avalanche time**

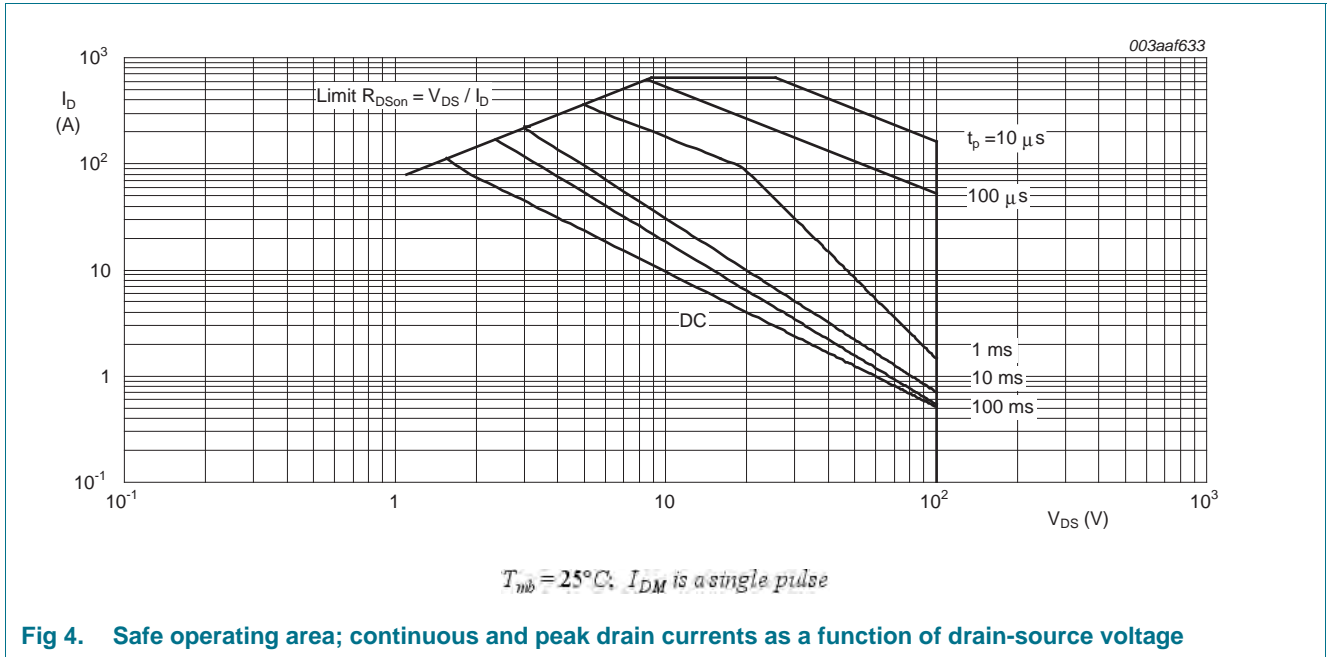


Fig 4. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

## 6. Thermal characteristics

Table 6. Thermal characteristics

| Symbol         | Parameter   | Conditions  | Min | Typ | Max  | Unit |
|----------------|---|---|-----|-----|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | see <a href="#">Figure 5</a>                          | -   | -   | 0.42 | K/W  |
| $R_{th(j-a)}$  | thermal resistance from junction to ambient       | minimum footprint; mounted on a printed-circuit board | -   | 50  | -    | K/W  |

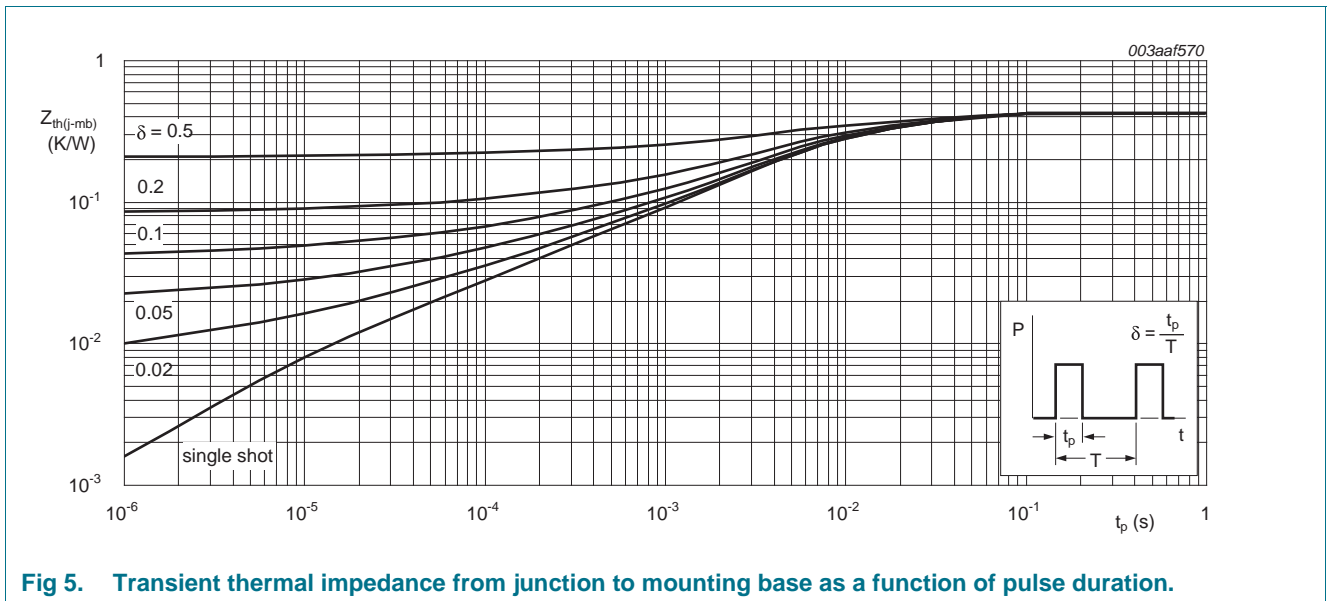
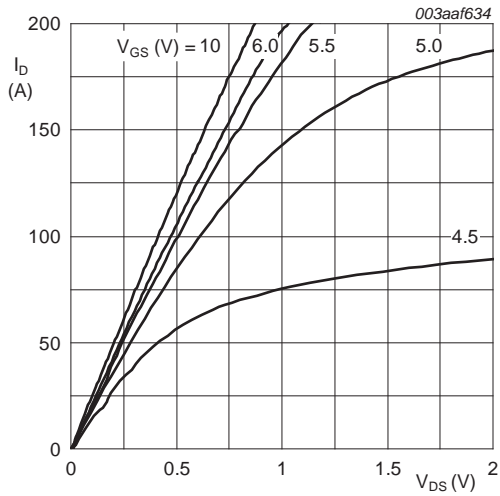


Fig 5. Transient thermal impedance from junction to mounting base as a function of pulse duration.

## 7. Characteristics

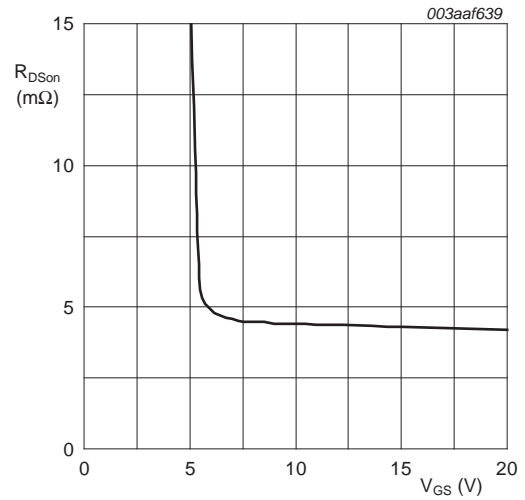
**Table 7. Characteristics**

| Symbol                         | Parameter                        | Conditions  | Min | Typ  | Max   | Unit       |
|--------------------------------|----------------------------------|---|-----|------|-------|------------|
| <b>Static characteristics</b>  |                                  |   |     |      |       |            |
| $V_{(BR)DSS}$                  | drain-source breakdown voltage   | $I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 \text{ }^\circ C$  | 100 | -    | -     | V          |
|                                |                                  | $I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 \text{ }^\circ C$   | 90  | -    | -     | V          |
| $V_{GS(th)}$                   | gate-source threshold voltage    | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ }^\circ C$ ; see <a href="#">Figure 9</a> ; see <a href="#">Figure 10</a>       | 2.4 | 3    | 4     | V          |
|                                |                                  | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ }^\circ C$ ; see <a href="#">Figure 9</a>                                      | 1   | -    | -     | V          |
|                                |                                  | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ }^\circ C$ ; see <a href="#">Figure 9</a>                                      | -   | -    | 4.5   | V          |
| $I_{DSS}$                      | drain leakage current            | $V_{DS} = 100 V; V_{GS} = 0 V; T_j = 25 \text{ }^\circ C$   | -   | 0.15 | 2     | $\mu A$    |
|                                |                                  | $V_{DS} = 100 V; V_{GS} = 0 V; T_j = 175 \text{ }^\circ C$  | -   | -    | 500   | $\mu A$    |
| $I_{GSS}$                      | gate leakage current             | $V_{GS} = 20 V; V_{DS} = 0 V; T_j = 25 \text{ }^\circ C$  | -   | 2    | 100   | nA         |
|                                |                                  | $V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25 \text{ }^\circ C$   | -   | 2    | 100   | nA         |
| $R_{DSon}$                     | drain-source on-state resistance | $V_{GS} = 10 V; I_D = 25 A; T_j = 25 \text{ }^\circ C$ ; see <a href="#">Figure 11</a>  | -   | 3.9  | 5     | m $\Omega$ |
|                                |                                  | $V_{GS} = 10 V; I_D = 25 A; T_j = 175 \text{ }^\circ C$ ; see <a href="#">Figure 11</a> ; see <a href="#">Figure 12</a>               | -   | -    | 13.5  | m $\Omega$ |
| <b>Dynamic characteristics</b> |                                  |   |     |      |       |            |
| $Q_{G(tot)}$                   | total gate charge                | $I_D = 25 A; V_{DS} = 80 V; V_{GS} = 10 V; T_j = 25 \text{ }^\circ C$ ; see <a href="#">Figure 13</a> ; see <a href="#">Figure 14</a> | -   | 180  | -     | nC         |
| $Q_{GS}$                       | gate-source charge               |   | -   | 34   | -     | nC         |
| $Q_{GD}$                       | gate-drain charge                |   | -   | 65   | -     | nC         |
| $C_{iss}$                      | input capacitance                | $V_{GS} = 0 V; V_{DS} = 25 V; f = 1 \text{ MHz}; T_j = 25 \text{ }^\circ C$ ; see <a href="#">Figure 15</a>                           | -   | 8860 | 11810 | pF         |
| $C_{oss}$                      | output capacitance               |   | -   | 770  | 925   | pF         |
| $C_{rss}$                      | reverse transfer capacitance     |   | -   | 546  | 750   | pF         |
| $t_{d(on)}$                    | turn-on delay time               | $V_{DS} = 80 V; R_L = 3.2 \Omega; V_{GS} = 10 V; R_{G(ext)} = 5 \Omega$   | -   | 37   | -     | ns         |
| $t_r$                          | rise time                        |   | -   | 62   | -     | ns         |
| $t_{d(off)}$                   | turn-off delay time              |   | -   | 158  | -     | ns         |
| $t_f$                          | fall time                        |   | -   | 80   | -     | ns         |
| $L_D$                          | internal drain inductance        | from upper edge of mounting base to centre of die   | -   | 2.5  | -     | nH         |
| $L_S$                          | internal source inductance       | measured from source lead to source bond pad; $T_j = 25 \text{ }^\circ C$   | -   | 7.5  | -     | nH         |
| <b>Source-drain diode</b>      |                                  |   |     |      |       |            |
| $V_{SD}$                       | source-drain voltage             | $I_S = 25 A; V_{GS} = 0 V; T_j = 25 \text{ }^\circ C$ ; see <a href="#">Figure 16</a>   | -   | 0.77 | 1.2   | V          |
| $t_{rr}$                       | reverse recovery time            | $I_S = 20 A; dI_S/dt = -100 A/\mu s; V_{GS} = 0 V; V_{DS} = 25 V$   | -   | 65   | -     | ns         |
| $Q_r$                          | recovered charge                 |   | -   | 191  | -     | nC         |



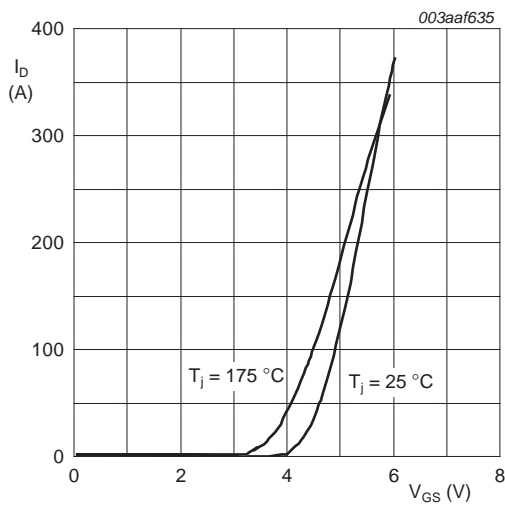
$T_j = 25\text{ }^\circ\text{C}; t_p = 300\text{ }\mu\text{s}$

**Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values**



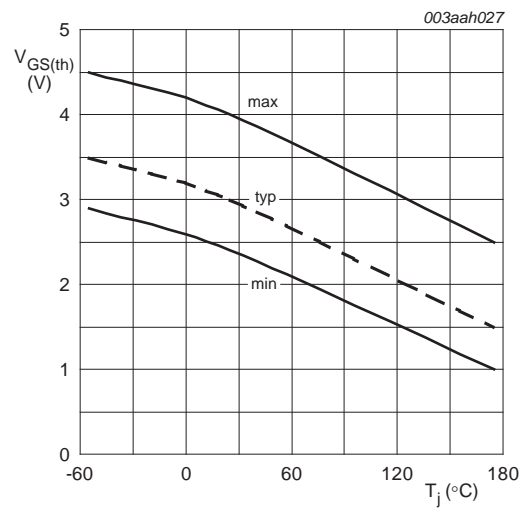
$T_j = 25\text{ }^\circ\text{C}; I_D = 25\text{ A}$

**Fig 7. Drain-source on-state resistance as a function of gate-source voltage; typical values**



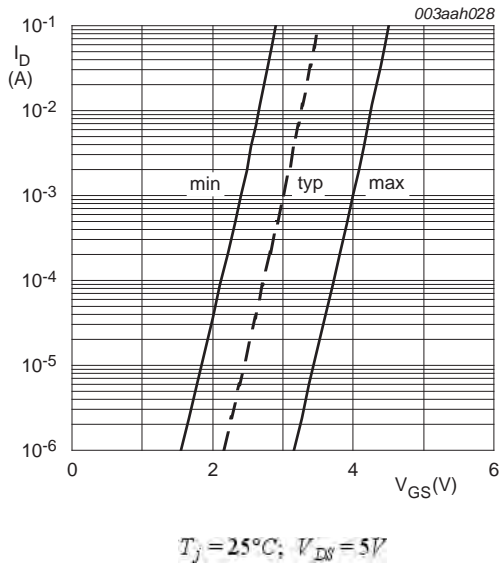
$V_{DS} = 12\text{ V}$

**Fig 8. Transfer characteristics: drain current as a function of gate-source voltage; typical values**

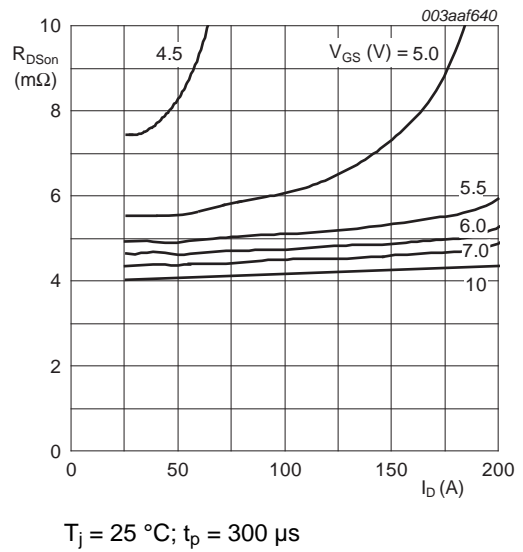


$I_D = 1\text{ mA}; V_{DS} = V_{GS}$

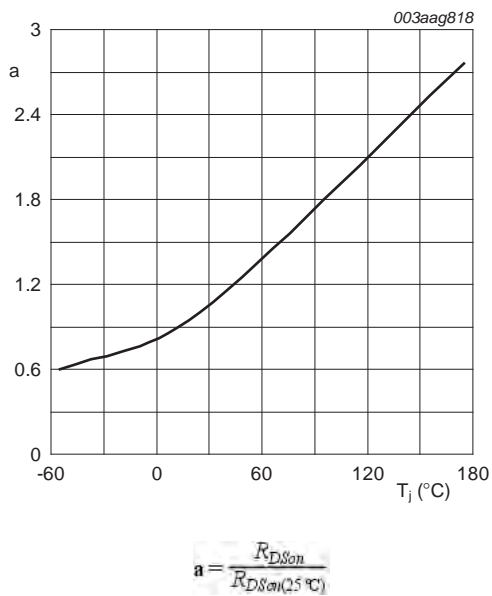
**Fig 9. Gate-source threshold voltage as a function of junction temperature**



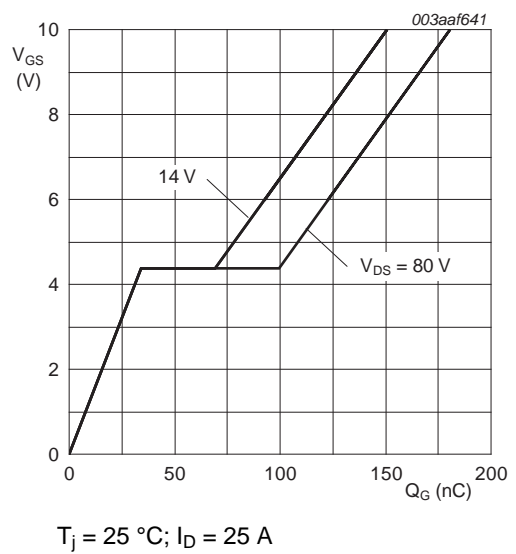
**Fig 10. Sub-threshold drain current as a function of gate-source voltage**



**Fig 11. Drain-source on-state resistance as a function of drain current; typical values**

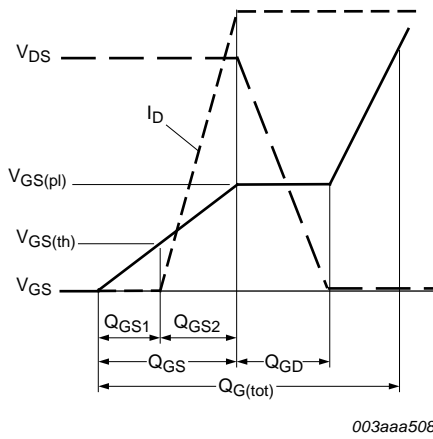


**Fig 12. Normalized drain-source on-state resistance factor as a function of junction temperature**

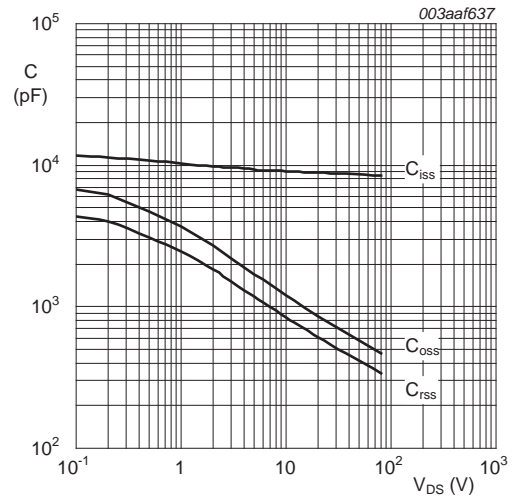


**Fig 13. Gate-source voltage as a function of gate charge; typical values**

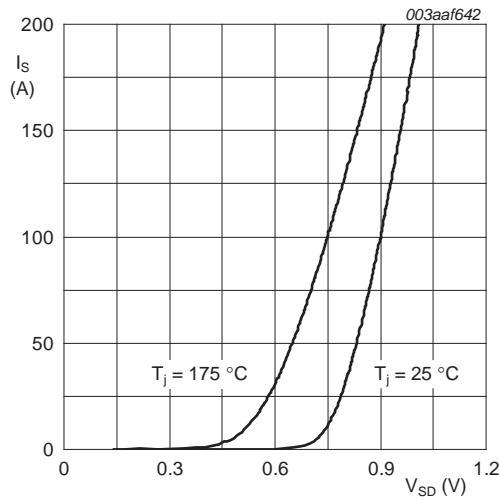




**Fig 14. Gate charge waveform definitions**



**Fig 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values**  
 $V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$



$V_{GS} = 0 \text{ V}$

**Fig 16. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values**

**8. Package outline**

Plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)

**SOT404**



**Fig 17. Package outline SOT404 (D2PAK)**

## 9. Revision history

Table 8. Revision history

| Document ID       | Release date  | Data sheet status    | Change notice | Supersedes        |
|-------------------|---|----------------------|---------------|-------------------|
| BUK765R0-100E v.2 | 20120516  | Product data sheet   | -             | BUK765R0-100E v.1 |
| Modifications:    | <ul style="list-style-type: none"><li>• Status changed from objective to product.</li><li>• Various changes to content.</li></ul> |                      |               |                   |
| BUK765R0-100E v.1 | 20120404  | Objective data sheet | -             | -                 |

## 10. Legal information

### 10.1 Data sheet status

| Document status <sup>[1] [2]</sup> | Product status <sup>[3]</sup> | Definition  |
|------------------------------------|-------------------------------|---|
| Objective [short] data sheet       | Development                   | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet     | Qualification                 | This document contains data from the preliminary specification.                       |
| Product [short] data sheet         | Production                    | This document contains the product specification.                                     |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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